

# International IOR Rectifier

INSULATED GATE BIPOLAR TRANSISTOR

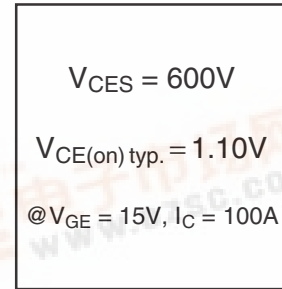
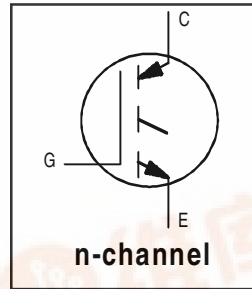
PD- 50070A

## GA200SA60S

Standard Speed IGBT

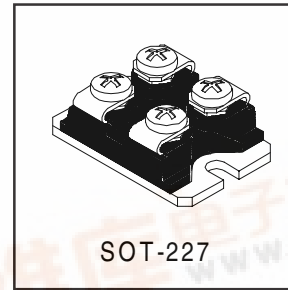
### Features

- Standard : Optimized for minimum saturation voltage and low operating frequencies up to 1kHz
- Lowest conduction losses available
- Fully isolated package ( 2,500 volt AC)
- Very low internal inductance ( 5 nH typ.)
- Industry standard outline



### Benefits

- Designed for increased operating efficiency in power conversion: UPS, SMPS, Welding, Induction heating
- Easy to assemble and parallel
- Direct mounting to heatsink
- Plug-in compatible with other SOT-227 packages



### Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Breakdown Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	200	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	100	
$I_{CM}$	Pulsed Collector Current ①	400	
$I_{LM}$	Clamped Inductive Load Current ②	400	
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	V
$E_{ARV}$	Reverse Voltage Avalanche Energy ③	155	mJ
$V_{ISOL}$	RMS Isolation Voltage, Any Terminal to Case, t=1 min	2500	V
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	630	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	250	
$T_J$	Operating Junction	-55 to + 150	°C
$T_{STG}$	Storage Temperature Range	-55 to + 150	
	Mounting Torque, 6-32 or M3 Screw	12 lbf •in(1.3N•m)	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	0.20	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.05	—	
$Wt$	Weight of Module	30	—	gm



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## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

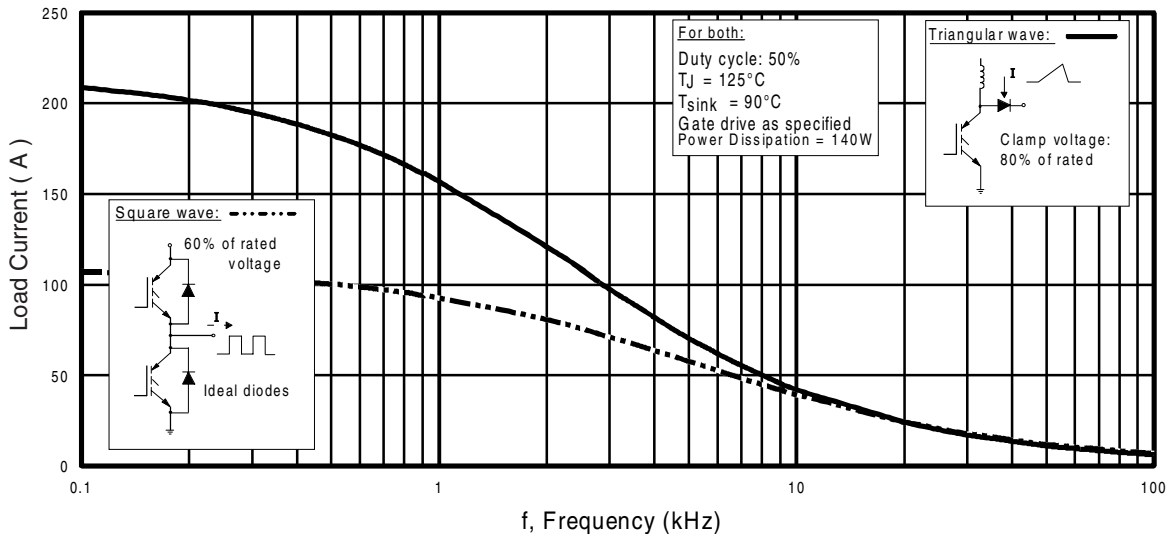
	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)CES</sub>	Collector-to-Emitter Breakdown Voltage	600	—	—	V	V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA
V <sub>(BR)ECS</sub>	Emitter-to-Collector Breakdown Voltage ④	18	—	—	V	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1.0A
ΔV <sub>(BR)CES/ΔT<sub>J</sub></sub>	Temperature Coeff. of Breakdown Voltage	—	0.62	—	V/°C	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1.0mA
V <sub>CE(ON)</sub>	Collector-to-Emitter Saturation Voltage	—	1.10	1.3	V	I <sub>C</sub> = 100A V <sub>GE</sub> = 15V
		—	1.33	—		I <sub>C</sub> = 200A See Fig.2, 5
		—	1.02	—		I <sub>C</sub> = 100A, T <sub>J</sub> = 150°C
V <sub>GE(th)</sub>	Gate Threshold Voltage	3.0	—	6.0		V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA
ΔV <sub>GE(th)/ΔT<sub>J</sub></sub>	Temperature Coeff. of Threshold Voltage	—	-10	—	mV/°C	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 2 mA
g <sub>fe</sub>	Forward Transconductance ⑤	90	150	—	S	V <sub>CE</sub> = 100V, I <sub>C</sub> = 100A
I <sub>CES</sub>	Zero Gate Voltage Collector Current	—	—	1.0	mA	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V
		—	—	10		V <sub>GE</sub> = 0V, V <sub>CE</sub> = 10V, T <sub>J</sub> = 150°C
I <sub>GES</sub>	Gate-to-Emitter Leakage Current	—	—	±250	nA	V <sub>GE</sub> = ±20V

## Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

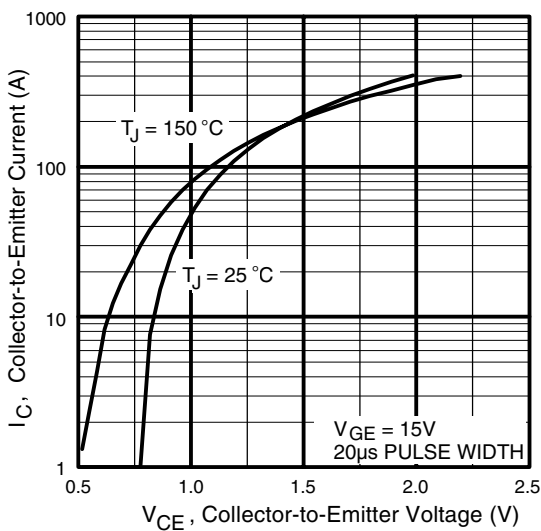
	Parameter	Min.	Typ.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge (turn-on)	—	770	1200	nC	I <sub>C</sub> = 100A
Q <sub>ge</sub>	Gate - Emitter Charge (turn-on)	—	100	150		V <sub>CC</sub> = 400V See Fig. 8
Q <sub>gc</sub>	Gate - Collector Charge (turn-on)	—	260	380		V <sub>GE</sub> = 15V
t <sub>d(on)</sub>	Turn-On Delay Time	—	78	—	ns	T <sub>J</sub> = 25°C I <sub>C</sub> = 100A, V <sub>CC</sub> = 480V V <sub>GE</sub> = 15V, R <sub>G</sub> = 2.0Ω Energy losses include "tail" See Fig. 9, 10, 13
t <sub>r</sub>	Rise Time	—	56	—		
t <sub>d(off)</sub>	Turn-Off Delay Time	—	890	1300		
t <sub>f</sub>	Fall Time	—	390	580		
E <sub>on</sub>	Turn-On Switching Loss	—	0.98	—	mJ	See Fig. 9, 10, 13
E <sub>off</sub>	Turn-Off Switching Loss	—	17.4	—		
E <sub>ts</sub>	Total Switching Loss	—	18.4	25.5		
t <sub>d(on)</sub>	Turn-On Delay Time	—	72	—	ns	T <sub>J</sub> = 150°C, I <sub>C</sub> = 100A, V <sub>CC</sub> = 480V V <sub>GE</sub> = 15V, R <sub>G</sub> = 2.0Ω Energy losses include "tail" See Fig. 10,11, 13
t <sub>r</sub>	Rise Time	—	60	—		
t <sub>d(off)</sub>	Turn-Off Delay Time	—	1500	—		
t <sub>f</sub>	Fall Time	—	660	—		
E <sub>ts</sub>	Total Switching Loss	—	35.7	—	mJ	
L <sub>E</sub>	Internal Emitter Inductance	—	5.0	—	nH	Between lead, and center of the die contact
C <sub>ies</sub>	Input Capacitance	—	16250	—	pF	V <sub>GE</sub> = 0V V <sub>CC</sub> = 30V See Fig. 7 f = 1.0MHz
C <sub>oes</sub>	Output Capacitance	—	1040	—		
C <sub>res</sub>	Reverse Transfer Capacitance	—	190	—		

### Notes:

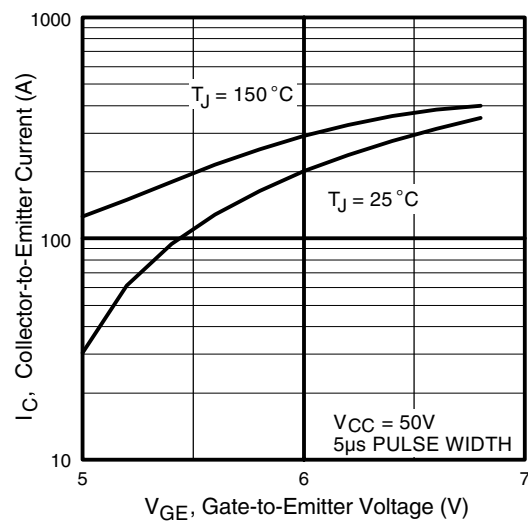
- ① Repetitive rating; V<sub>GE</sub> = 20V, pulse width limited by max. junction temperature. ( See fig. 15 )
- ② V<sub>CC</sub> = 80%(V<sub>CES</sub>), V<sub>GE</sub> = 20V, L = 10μH, R<sub>G</sub> = 2.0Ω, (See fig. 14)
- ③ Repetitive rating; pulse width limited by maximum junction temperature.
- ④ Pulse width ≤ 80μs; duty factor ≤ 0.1%.
- ⑤ Pulse width 5.0μs, single shot.



**Fig. 1** - Typical Load Current vs. Frequency  
(Load Current =  $I_{\text{RMS}}$  of fundamental)



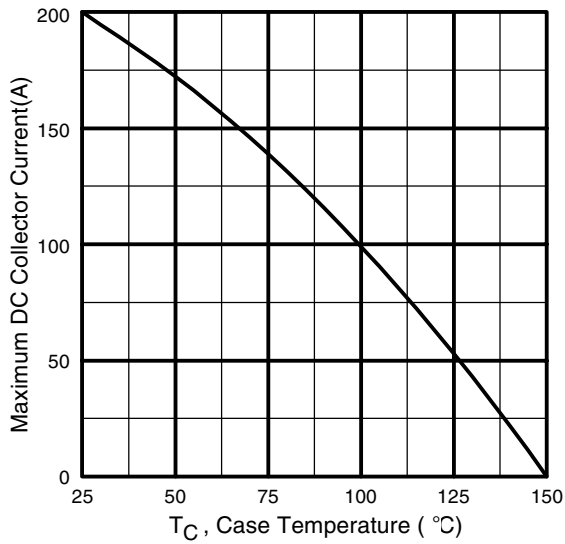
**Fig. 2** - Typical Output Characteristics



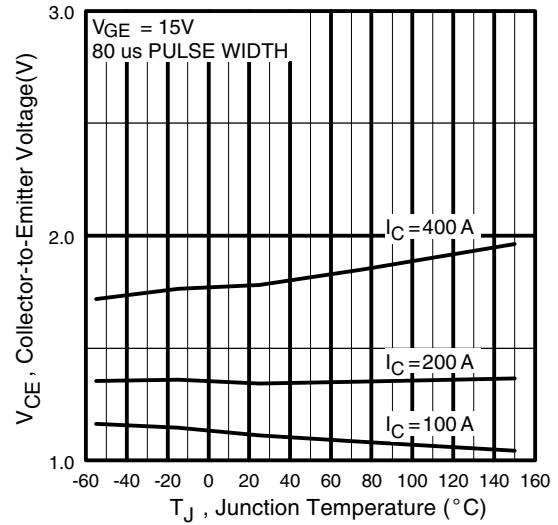
**Fig. 3** - Typical Transfer Characteristics

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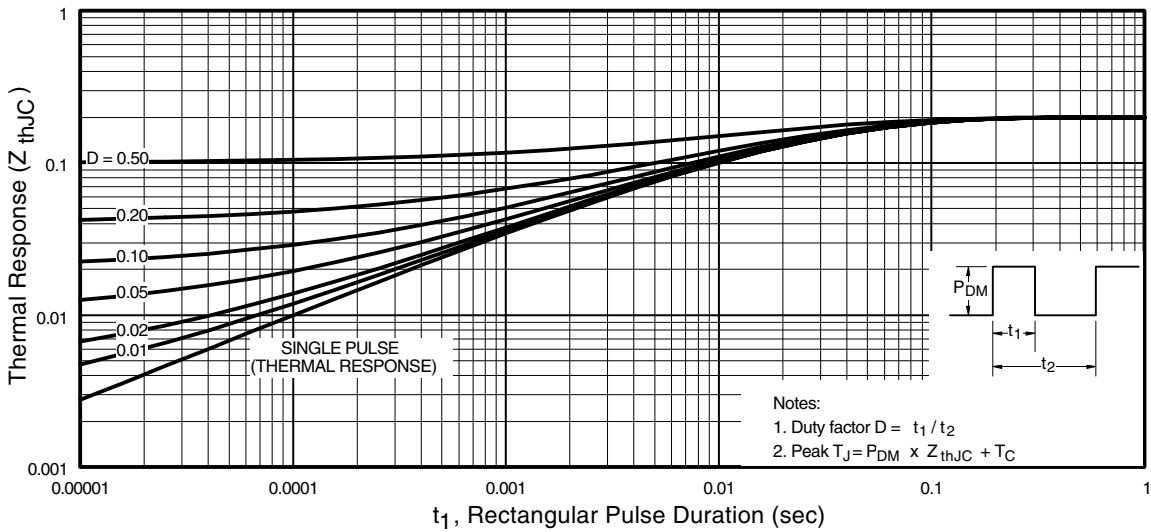
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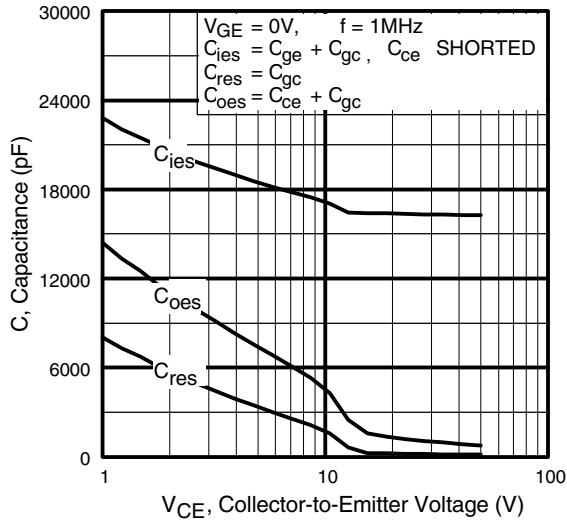
**Fig. 4** - Maximum Collector Current vs. Case Temperature



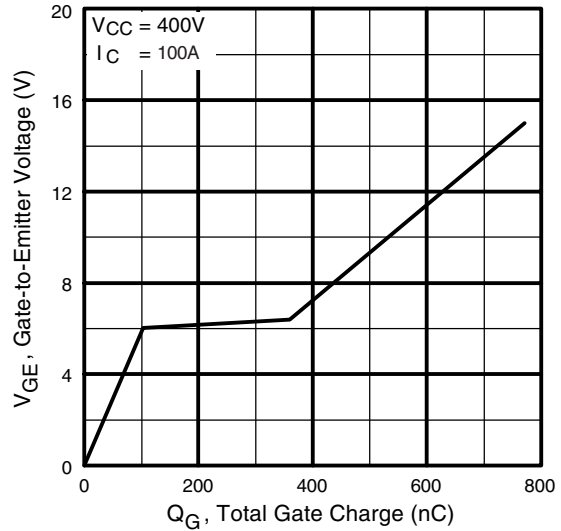
**Fig. 5** - Typical Collector-to-Emitter Voltage vs. Junction Temperature



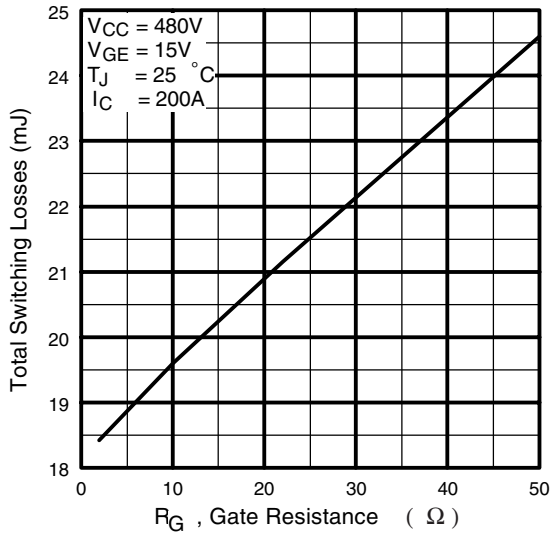
**Fig. 6** - Maximum Effective Transient Thermal Impedance, Junction-to-Case



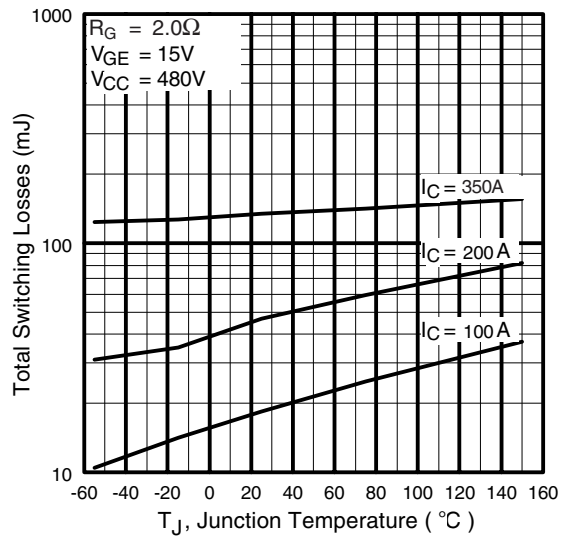
**Fig. 7** - Typical Capacitance vs. Collector-to-Emitter Voltage



**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage



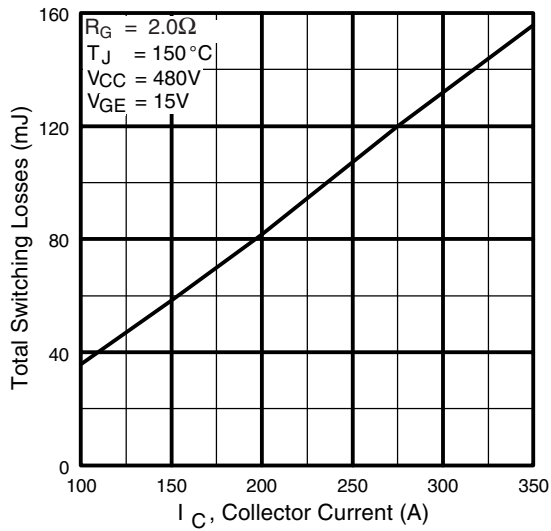
**Fig. 9** - Typical Switching Losses vs. Gate Resistance



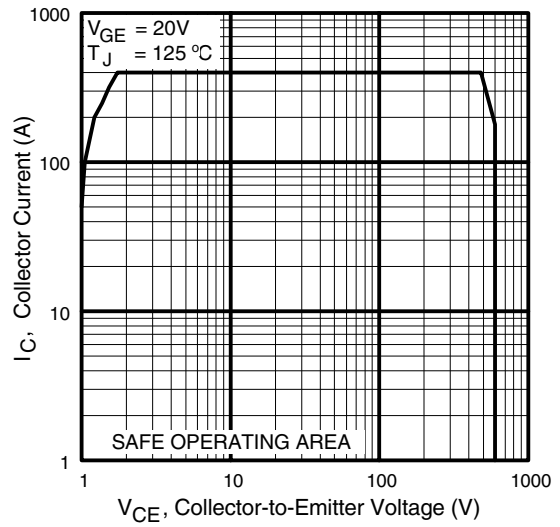
**Fig. 10** - Typical Switching Losses vs. Junction Temperature

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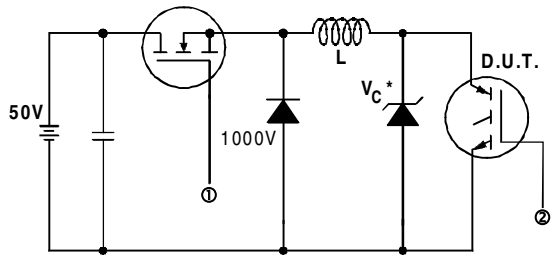
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**Fig. 11** - Typical Switching Losses vs. Collector Current

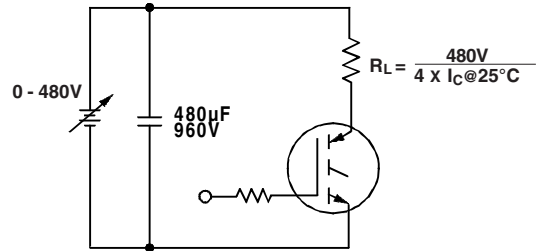


**Fig. 12** - Turn-Off SOA

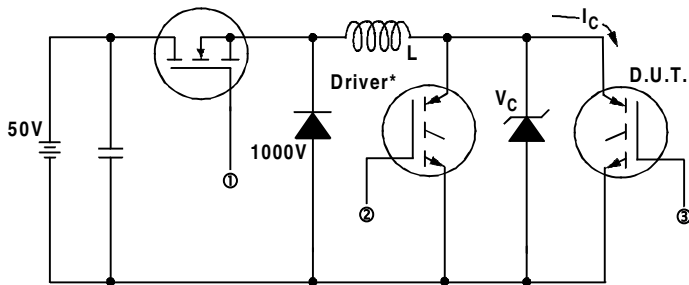


\* Driver same type as D.U.T.;  $V_c = 80\%$  of  $V_{ce(max)}$   
 \* Note: Due to the 50V power supply, pulse width and inductor will increase to obtain rated Id.

**Fig. 13a** - Clamped Inductive Load Test Circuit

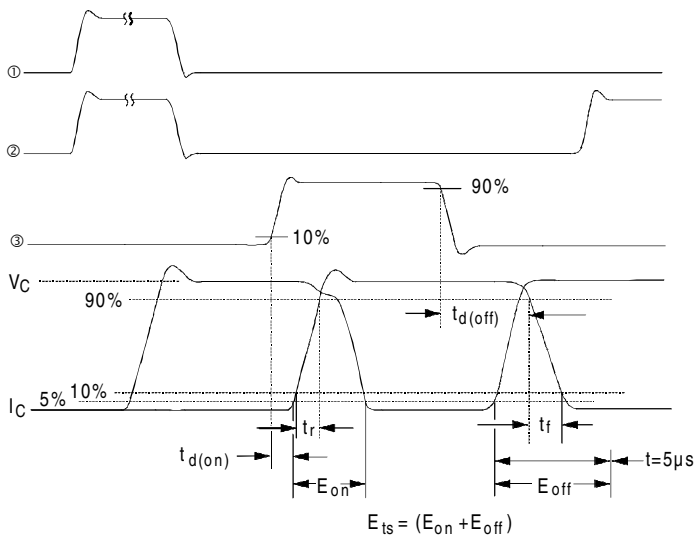


**Fig. 13b** - Pulsed Collector Current Test Circuit



**Fig. 14a** - Switching Loss Test Circuit

\* Driver same type as D.U.T.,  $V_C = 480V$



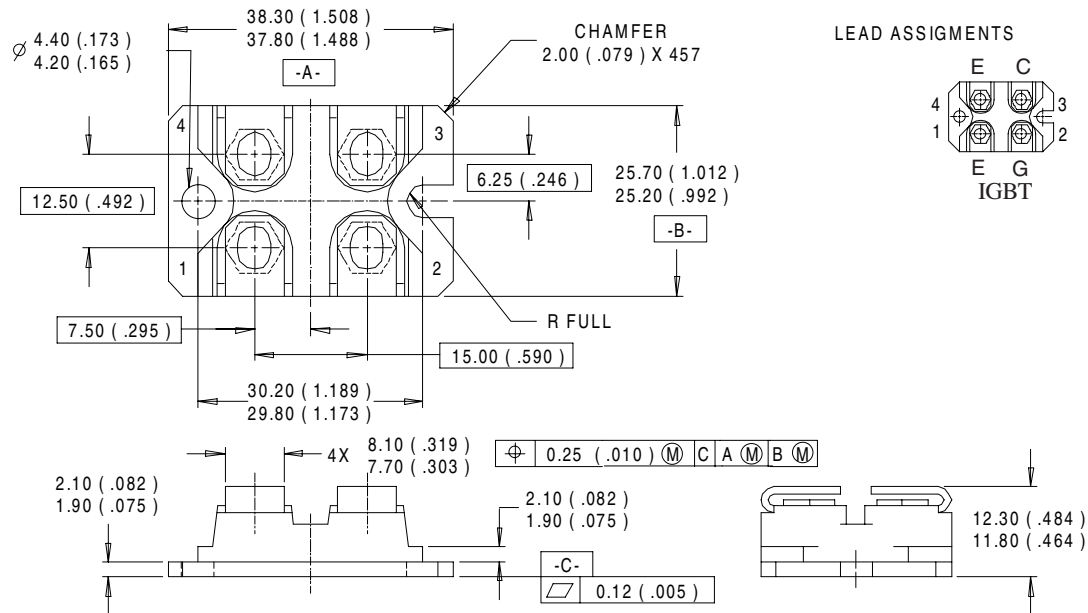
**Fig. 14b** - Switching Loss Waveforms

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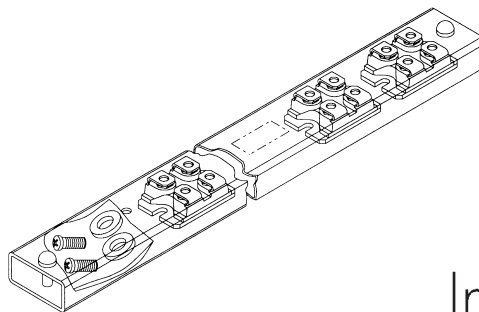
## SOT-227 Package Details

Dimensions are shown in millimeters ( inches )



## Tube

QUANTITIES PER TUBE IS 10  
M4 SCREW AND WASHER INCLUDED



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**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
**IR EUROPEAN REGIONAL CENTRE:** 439/445 Godstone Rd, Whyteleafe, Surrey CR3 OBL, UK Tel: ++ 44 (0)20 8645 8000  
**IR CANADA:** 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200  
**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 (0) 6172 96590  
**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 011 451 0111  
**IR JAPAN:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo 171 Tel: 81 (0)3 3983 0086  
**IR SOUTHEAST ASIA:** 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: ++ 65 (0)838 4630  
**IR TAIWAN:** 16 Fl. Suite D. 207, Sec. 2, Tun Haw South Road, Taipei, 10673 Tel: 886-(0)2 2377 9936  
*Data and specifications subject to change without notice. 4/00*